

Notice of References Cited

Application/Control No.

10/525,707

Applicant(s)/Patent Under
Reexamination
FUNATSU ET AL.

Examiner

David M. Naff

Art Unit

1657

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,284,451	09-2001	Funatsu et al.	435/1.1
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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